

**Notice of References Cited**

Application/Control No.

09/660,484

Applicant(s)/Patent Under  
Reexamination  
TANAKA, YASUO

Examiner

Suk-San Foong

Art Unit

2823

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,383,659	05-2002	Honda et al.	428/620
	B	US-6,210,811	04-2001	Honda et al.	428/620
	C	US-6,338,767	01-2002	Nakatani et al.	156/233
	D	US-6,113,728	09-2000	Tsukagoshi et al.	156/264
	E	US-5,726,222	03-1998	Sawaoka et al.	523/211
	F	US-6,447,915	09-2002	Komiyatani et al.	428/416
	G	US-6,392,217	05-2002	Teranuma et al.	250/208.1
	H	US-2001/0005548	06-2001	Farquhar et al.	428/325
	I	US-6,150,435	11-2000	Bayer et al.	523/434
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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